#### **AUTOMOTIVE GRADE**

# International Rectifier

## AUIRF3205

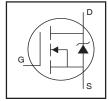
HEXFET® Power MOSFET

#### **Features**

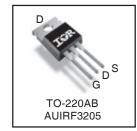
- Advanced Planar Technology
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified\*

#### **Description**

Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V <sub>(BR)DSS</sub>	55V
R <sub>DS(on)</sub> max.	$\mathbf{8.0m}\Omega$
I <sub>D (Silicon Limited)</sub>	110A⑤
D (Package Limited)	75A



G	D	S
Gate	Drain	Source

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature  $(T_*)$  is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	110⑤	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	80⑤	Α
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	75	
I <sub>DM</sub>	Pulsed Drain Current ①	390	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	٧
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) <sup>②</sup>	264⑦	mJ
I <sub>AR</sub>	Avalanche Current ①	62	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①®	20	mJ
$T_J$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

#### Thermal Resistance

	Parameter	Тур.	Max.	Units		
$R_{\theta JC}$	Junction-to-Case ®		0.75			
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W		
$R_{\theta JA}$	Junction-to-Ambient		62			

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/

#### Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.057		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			8.0	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 62A <sup>(4)</sup>
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	٧	$V_{DS} = V_{GS}, I_D = 250 \mu A$
gfs	Forward Transconductance	44			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 62A ④
I <sub>DSS</sub>	Drain-to-Source Leakage Current			25	μΑ	$V_{DS} = 55V, V_{GS} = 0V$
				250		$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$

### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

,	Parameter   Min.   Typ.   Max.   Units   Conditions					Conditions
_		IVIIII.	Typ.		Office	
$Q_g$	Total Gate Charge			146		$I_D = 62A$
$Q_{gs}$	Gate-to-Source Charge			35	nC	$V_{DS} = 44V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge			54		V <sub>GS</sub> = 10V, See Fig. 6 & 13 ④
t <sub>d(on)</sub>	Turn-On Delay Time		14			$V_{DD} = 28V$
t <sub>r</sub>	Rise Time		101			$I_D = 62A$
t <sub>d(off)</sub>	Turn-Off Delay Time		50		ns	$R_G = 4.5 \Omega$
t <sub>f</sub>	Fall Time		65			V <sub>GS</sub> = 10V, See Fig. 10 ⊕
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead,
					nΗ	6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5			from package
						and center of die contact
C <sub>iss</sub>	Input Capacitance		3247			$V_{GS} = 0V$
Coss	Output Capacitance		781		pF	$V_{DS} = 25V$
C <sub>rss</sub>	Reverse Transfer Capacitance		211			f = 1.0MHz, See Fig. 5

#### **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current	T		110		MOSFET symbol
	(Body Diode)				Α	showing the
I <sub>SM</sub>	Pulsed Source Current	l		390		integral reverse
	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 62A$ , $V_{GS} = 0V$ ④
t <sub>rr</sub>	Reverse Recovery Time		69	104	ns	$T_J = 25^{\circ}C, I_F = 62A$
Q <sub>rr</sub>	Reverse Recovery Charge		143	215	nC	di/dt = 100A/µs ④
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	turn-or	time is	negligib	le (turn-on is dominated by LS+LD)

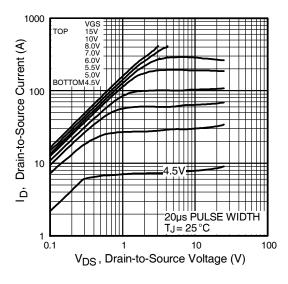
#### Notes:

- Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting  $T_J = 25$ °C,  $L = 138\mu H$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 62A$ . (See Figure 12)
- $\label{eq:loss} \begin{array}{l} \text{ $I_{SD} \leq 62A$, di/dt \leq 207A/\mu s, $V_{DD} \leq V_{(BR)DSS}$,} \\ \text{ $T_{J} \leq 175^{\circ}C$.} \end{array}$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- ⑤ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ⑤ This is a typical value at device destruction and represents operation outside rated limits.
- $\ \ \$  This is a calculated value limited to  $T_J = 175^{\circ}C$ .

#### Qualification Information<sup>†</sup>

Qualifica	uon imormation					
		Automotive				
		(per AEC-Q101) <sup>††</sup>				
Qualification	on Level	Comments: This part number(s) passed Automotive qualifications and Consumer qualification level is granted extension of the higher Automotive level.				
Moisture S	ensitivity Level	TO-220 N/A				
	Machine Model	Class M4 (+/- 600V) <sup>†††</sup>				
		AEC-Q101-002				
	Human Body Model		Class H1C (+/- 2000V) <sup>†††</sup>			
ESD			AEC-Q101-001			
	Charged Device Model		Class C5 (+/- 2000V) <sup>†††</sup>			
			AEC-Q101-005			
RoHS Com	pliant	Yes				

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.
- ††† Highest passing voltage.



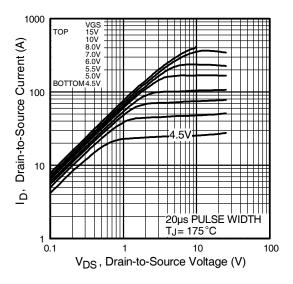
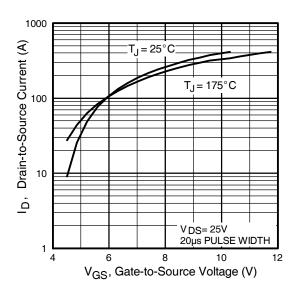


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



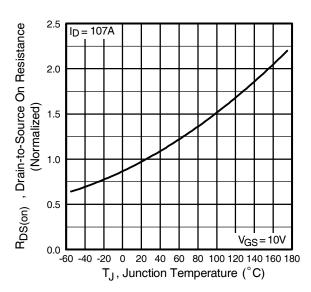
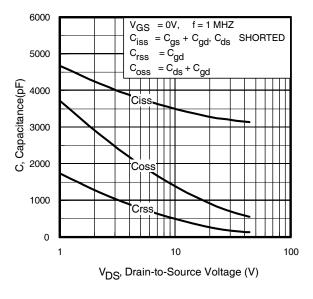
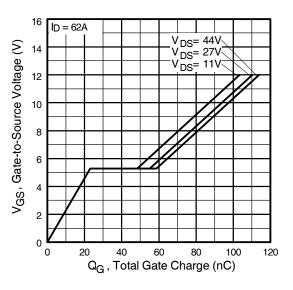


Fig 3. Typical Transfer Characteristics

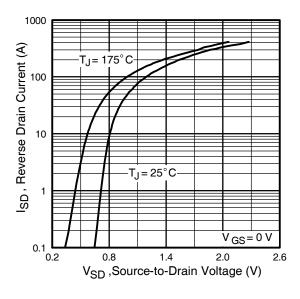
**Fig 4.** Normalized On-Resistance Vs. Temperature





**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



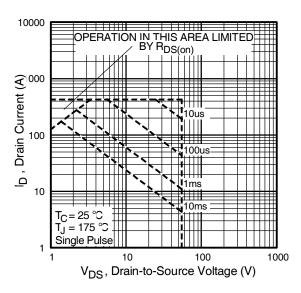
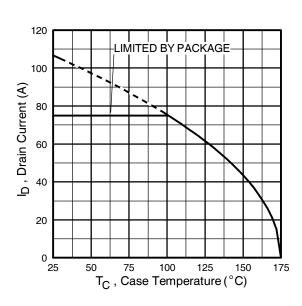


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area



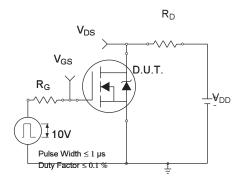


Fig 10a. Switching Time Test Circuit

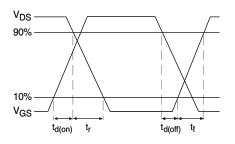


Fig 9. Maximum Drain Current Vs.
Case Temperature

Fig 10b. Switching Time Waveforms

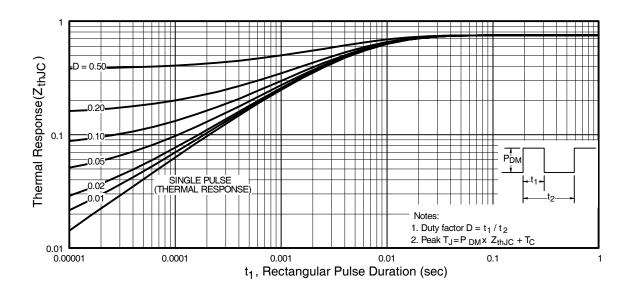


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

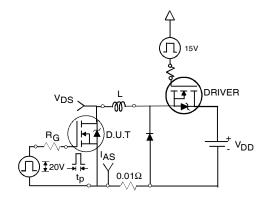


Fig 12a. Unclamped Inductive Test Circuit

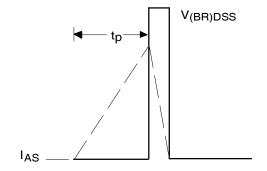


Fig 12b. Unclamped Inductive Waveforms

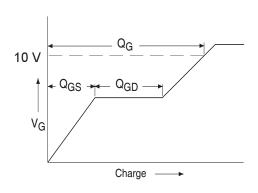


Fig 13a. Basic Gate Charge Waveform

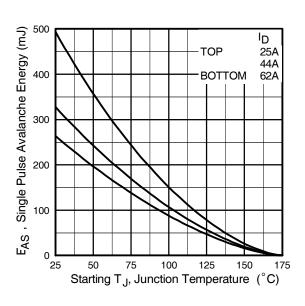


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

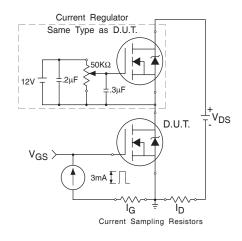
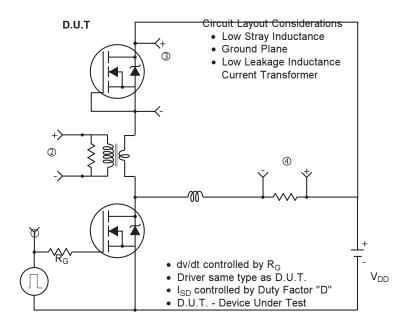
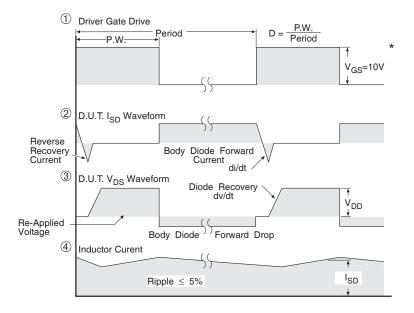


Fig 13b. Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



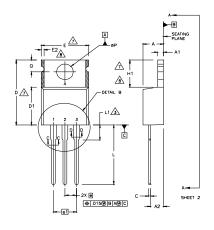


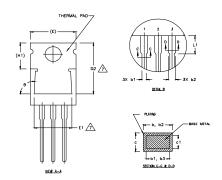
<sup>\*</sup>  $V_{GS}$  = 5V for Logic Level Devices

Fig 14. For N-Channel HEXFETS

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)





SYMBOL

A1 A2

b b1 b2 b3

c c1

D1 D2

E E1

e e1 H1

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M— 1994,
  DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS],
  LEAD DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS],
  LEAD DIMENSION AND FINISH LUNCONTROLLED IN L1.
  DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH
  SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE
  MEASURED AT THE OUTERWOST EXTREMES OF THE PLASTIC BODY,
  DIMENSION 1 A c1 APPLY TO BASE METAL ONLY.
  CONTROLLING DIMENSION: INCHES.
  THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E.H1.D2 & E1

4.82

1.40

2.92 1,01

0.96 1.77 1.73

16.51

9.02 12.88

10.66 8.89

14,73 6.35 4.08

DIMENSIONS

INCHES

.190

.055

,040

.068

.650

.355 .507

.420

.250

MIN.

.140

.080 .015

.045

.560

.380 .330

NOTES

4,7

7,8

DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

MILLIMETERS

MIN. 3.56

2.04

0.38 1,15

14,22

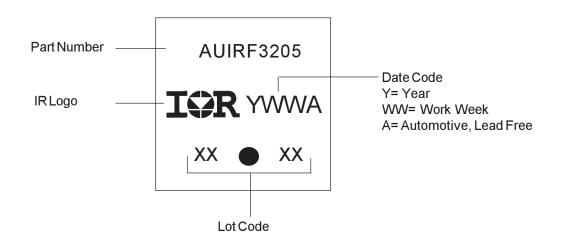
8.38

12.70

#### LEAD ASSIGNMENTS

HEXFET

## TO-220AB Part Marking Information



## **Ordering Information**

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF3205	TO-220	Tube	50	AUIRF3205

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